

Low Loss IGBT: IGBT in TRENCHSTOP™ and Fieldstop technology







Features:

- Very low V_{CE(sat)} 1.5V (typ.)
- Maximum Junction Temperature 175°C
- Short circuit withstand time 5µs
- Designed for frequency inverters for washing machines, fans, pumps and vacuum cleaners
- TRENCHSTOP™ technology for 600V applications offers :
 - very tight parameter distribution
 - high ruggedness, temperature stable behavior
 - very high switching speed
- Positive temperature coefficient in V_{CE(sat)}
- Low EMI
- Low Gate Charge
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹ for target applications
- Complete product spectrum and PSpice Models : http://www.infineon.com/igbt/





Туре	$V_{\sf CE}$	I _C	V _{CE(sat),Tj=25°C}	$T_{\rm j,max}$	Marking	Package
IGB50N60T	600 V	50 A	1.5 V	175 °C	G50T60	PG-TO263-3

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage, <i>T</i> _j ≥ 25°C	V _{CE}	600	V
DC collector current, limited by T_{jmax}			
$T_{\rm C}$ = 25°C, value limited by bondwire	I _C	90	
$T_{\rm C}$ = 100°C		64	Α
Pulsed collector current, t_p limited by T_{jmax}	I _{Cpuls}	150	
Turn off safe operating area, $V_{CE} = 600 \text{V}$, $T_j = 175 ^{\circ}\text{C}$, $t_p = 1 \mu\text{s}$	-	150	
Gate-emitter voltage	V _{GE}	±20	V
Short circuit withstand time ²⁾	4	F	
$V_{\text{GE}} = 15\text{V}, \ V_{\text{CC}} \le 400\text{V}, \ T_{\text{j}} \le 150^{\circ}\text{C}$	t_{SC}	5	μS
Power dissipation $T_C = 25^{\circ}C$	P _{tot}	333	W
Operating junction temperature	$T_{\rm j}$	-40+175	
Storage temperature	$T_{\rm stg}$	-55+150	°C
Soldering temperature (reflow soldering, MSL1)	-	260	

¹ J-STD-020 and JESD-022

²⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.





Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				•
IGBT thermal resistance,	R _{thJC}		0.45	K/W
junction – case				
Thermal resistance,	R_{thJA}	6cm² Cu	40	
junction – ambient				

Electrical Characteristic, at $T_j = 25$ °C, unless otherwise specified

Desembles	Cumbal	Symbol Conditions		Value		
Parameter	Symbol Conditions		min.	Тур.	max.	Unit
Static Characteristic						
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{\rm GE} = 0 \text{V}, I_{\rm C} = 0.2 \text{mA}$	600	-	-	V
Collector-emitter saturation voltage	V _{CE(sat)}	$V_{\rm GE} = 15 \rm V, \ I_{\rm C} = 50 \rm A$				
		<i>T</i> _j =25°C	-	1.5	2.0	
		<i>T</i> _j =175°C	-	1.9	-	
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =0.8mA, $V_{\rm CE}$ = $V_{\rm GE}$	4.1	4.9	5.7	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V				μΑ
		<i>T</i> _j =25°C	-	-	40	
		<i>T</i> _j =175°C	-	-	3500	
Gate-emitter leakage current	I _{GES}	$V_{\text{CE}}=0\text{V}, V_{\text{GE}}=20\text{V}$	-	-	100	nA
Transconductance	g_{fs}	$V_{CE} = 20V, I_{C} = 50A$	-	31	-	S
Integrated gate resistor	R _{Gint}			-		Ω

Dynamic Characteristic

Input capacitance	Ciss	V _{CE} =25V,	-	3140	-	pF
Output capacitance	Coss	$V_{GE}=0V$,	-	200	-	
Reverse transfer capacitance	Crss	<i>f</i> =1MHz	-	93	-	
Gate charge	Q _{Gate}	$V_{\rm CC} = 480 \text{V}, I_{\rm C} = 50 \text{A}$	-	310	-	nC
		V _{GE} =15V				
Internal emitter inductance	L _E		-	7	-	nH
measured 5mm (0.197 in.) from case						
Short circuit collector current ¹⁾	$I_{C(SC)}$	$V_{\text{GE}} = 15 \text{V}, t_{\text{SC}} \le 5 \mu \text{s}$ $V_{\text{CC}} = 400 \text{V},$ $T_{\text{j}} \le 150 ^{\circ} \text{C}$	-	458.3	-	A

¹⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.



IGB50N60T

TRENCHSTOP™ Series

Switching Characteristic, Inductive Load, at T_j =25 °C

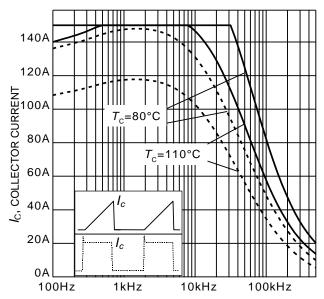
Devemeter	Cumbal	Conditions	Value			I Imia
Parameter	Symbol	Conditions	min.	Тур.	max.	Unit
IGBT Characteristic						
Turn-on delay time	$t_{d(on)}$	$T_{\rm j} = 25^{\circ} \text{C},$	-	26	-	ns
Rise time	t_{r}	$V_{CC} = 400 \text{V}, I_{C} = 50 \text{A}, V_{GE} = 0/15 \text{V}, r_{G} = 7\Omega,$	-	29	-	
Turn-off delay time	$t_{d(off)}$	L_{σ} =103nH, C_{σ} =39pF L_{σ} , C_{σ} from Fig. E Energy losses include "tail" and diode reverse	-	299	-	
Fall time	t_{f}		-	29	-	
Turn-on energy	Eon		-	1.2	-	mJ
Turn-off energy	E _{off}	recovery.	-	1.4	-	
Total switching energy	E _{ts}	Diode from IKW50N60T		2.6	-	

Switching Characteristic, Inductive Load, at T_i =150 °C

Davameter	Symbol	Conditions	Value			I Imia
Parameter	Symbol	Conditions	min.	Тур.	max.	Unit
IGBT Characteristic	·					
Turn-on delay time	$t_{d(on)}$	T _j =175°C,	-	27	-	ns
Rise time	t _r	$V_{CC}=400V, I_{C}=50A, V_{GE}=0/15V, r_{G}=7\Omega,$	-	33	-	
Turn-off delay time	t _{d(off)}	$L_{\sigma}=103\text{nH}, C_{\sigma}=39\text{pF}$	-	341	-	
Fall time	t_{f}	L_{σ} , C_{σ} from Fig. E Energy losses include	-	55	-	
Turn-on energy	Eon	"tail" and diode reverse	-	1.8	-	mJ
Turn-off energy	E _{off}	recovery. Diode from IKW50N60T	-	1.8	-	
Total switching energy	E _{ts}		-	3.6	-	

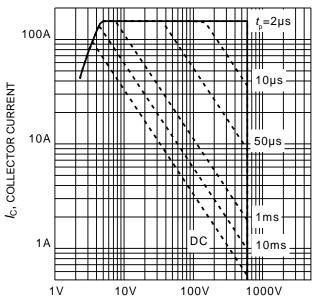






f, SWITCHING FREQUENCY

Figure 1. Collector current as a function of switching frequency $(T_j \le 175^{\circ}\text{C}, D = 0.5, V_{\text{CE}} = 400\text{V}, V_{\text{GE}} = 0/15\text{V}, r_{\text{G}} = 7\Omega)$



 V_{CE} , COLLECTOR-EMITTER VOLTAGE

Figure 2. Safe operating area $(D=0, T_C=25^{\circ}\text{C}, T_j \leq 175^{\circ}\text{C}; V_{\text{GE}}=0/15\text{V})$

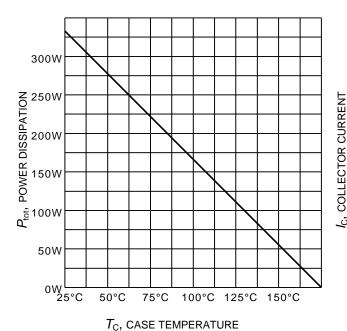
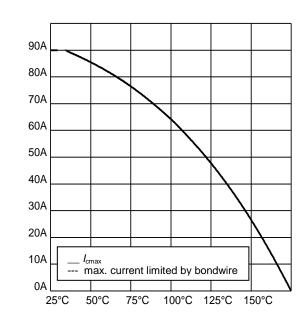


Figure 3. Power dissipation as a function of case temperature

 $(T_{i} \le 175^{\circ}C)$



 $T_{\rm C}$, CASE TEMPERATURE

Figure 4. Collector current as a function of case temperature

 $(V_{GE} \ge 15V, T_j \le 175^{\circ}C)$





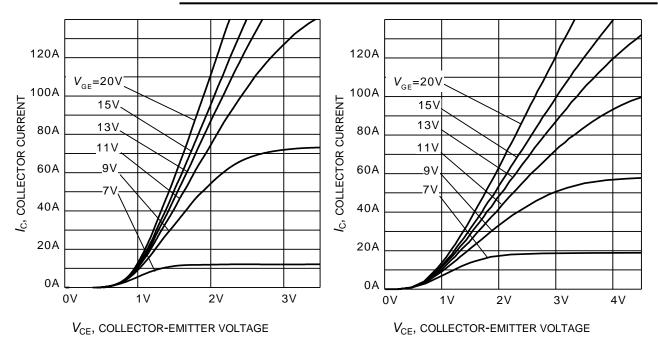


Figure 5. Typical output characteristic $(T_i = 25^{\circ}C)$

Figure 6. Typical output characteristic $(T_i = 175^{\circ}C)$

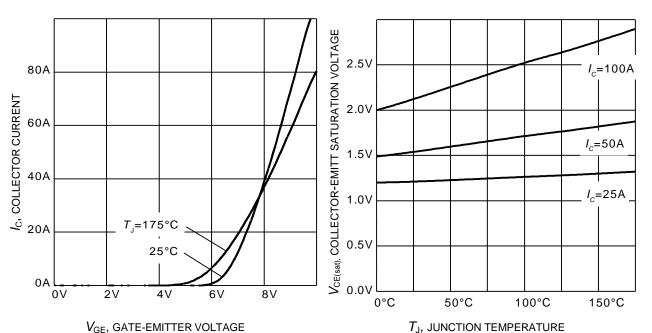
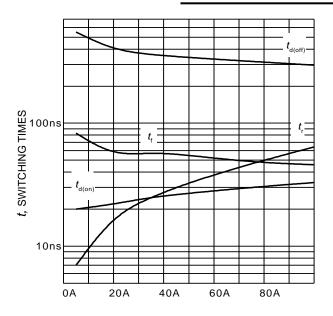


Figure 7. Typical transfer characteristic $(V_{CE}=20V)$

Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature $(V_{GE} = 15V)$







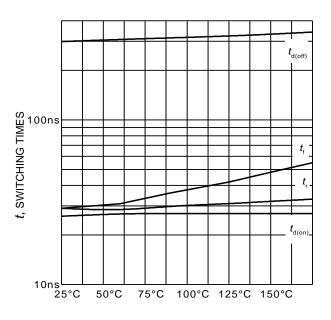
 $t_{d(off)}$ t_{r} t_{r} t_{r} $t_{d(on)}$ t_{r} $t_{d(on)}$ t_{r} $t_{d(on)}$ t_{r} $t_{d(on)}$ t_{r} t_{r}

 $I_{\rm C}$, COLLECTOR CURRENT

Figure 9. Typical switching times as a function of collector current (inductive load, T_J =175°C, V_{CE} = 400V, V_{GE} = 0/15V, r_G = 7 Ω , Dynamic test circuit in Figure E)

 $R_{\rm G}$, gate resistor

Figure 10. Typical switching times as a function of gate resistor (inductive load, $T_J = 175$ °C, $V_{CE} = 400$ V, $V_{GE} = 0/15$ V, $I_C = 50$ A, Dynamic test circuit in Figure E)



7V 6V V_{GE(th)}, GATE-EMITT TRSHOLD VOLTAGE max. typ. 5√ 4V min. 3V 2V 1 V 50°C -50°C 0°C 100°C 150°C

 $T_{\rm J}$, JUNCTION TEMPERATURE

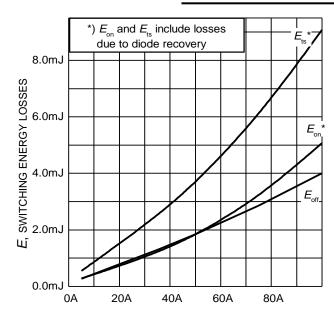
Figure 11. Typical switching times as a function of junction temperature (inductive load, $V_{\rm CE}$ = 400V, $V_{\rm GE}$ = 0/15V, $I_{\rm C}$ = 50A, $r_{\rm G}$ =7 Ω , Dynamic test circuit in Figure E)

 $T_{\rm J}$, JUNCTION TEMPERATURE

Figure 12. Gate-emitter threshold voltage as a function of junction temperature $(I_C = 0.8 \text{mA})$







*) E_{on} and E_{ts} include losses due to diode recovery 6.0m E_{ts} SWITCHING ENERGY LOSSES 5.0mJ 4.0mJ 3.0mJ 2.0mJ ш ́ 1.0mJ 0.0mJ 0Ω 10Ω 20Ω

 $I_{\rm C}$, COLLECTOR CURRENT

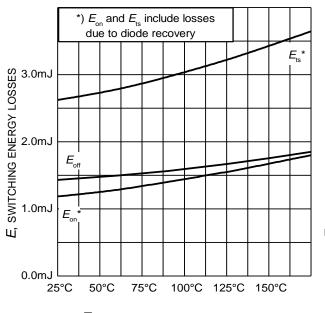
Figure 13. Typical switching energy losses

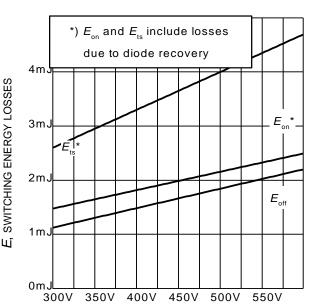
as a function of collector current (inductive load, $T_J = 175$ °C, $V_{CE} = 400 \text{V}, \ V_{GE} = 0/15 \text{V}, \ r_{G} = 7\Omega,$ Dynamic test circuit in Figure E)

R_G, GATE RESISTOR

Figure 14. Typical switching energy losses as a function of gate resistor

(inductive load, $T_J = 175$ °C, $V_{CE} = 400 \text{V}, V_{GE} = 0/15 \text{V}, I_{C} = 50 \text{A},$ Dynamic test circuit in Figure E)





 $T_{\rm J}$, JUNCTION TEMPERATURE

Figure 15. Typical switching energy losses as a function of junction temperature

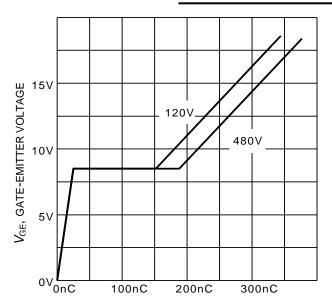
(inductive load, $V_{CE} = 400 \text{V}$, $V_{GE} = 0/15V$, $I_{C} = 50A$, $r_{G} = 7\Omega$ Dynamic test circuit in Figure E) V_{CE} , COLLECTOR-EMITTER VOLTAGE

Figure 16. Typical switching energy losses as a function of collector emitter voltage

(inductive load, $T_J = 175^{\circ}$ C, $V_{\rm GE} = 0/15 \,\rm V$, $I_{\rm C} = 50 \,\rm A$, $r_{\rm G} = 7 \,\rm \Omega$, Dynamic test circuit in Figure E)







1nF

1nF

100pF

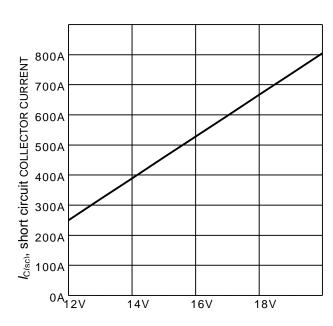
0V 10V 20V 30V 40V

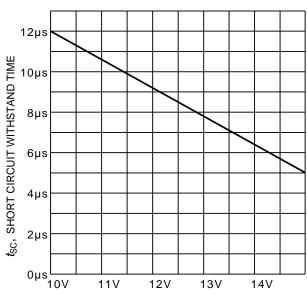
 Q_{GE} , GATE CHARGE

Figure 17. Typical gate charge $(I_C=50 \text{ A})$

 $V_{\rm CE}$, COLLECTOR-EMITTER VOLTAGE

Figure 18. Typical capacitance as a function of collector-emitter voltage $(V_{GE}=0V, f=1 \text{ MHz})$





 $V_{\rm GE}$, GATE-EMITTETR VOLTAGE

Figure 19. Typical short circuit collector current as a function of gate-emitter voltage $(V_{CE} \le 400 \text{V}, T_i \le 150 ^{\circ}\text{C})$

 $V_{\rm GE}$, gate-emitetr voltage

Figure 20. Short circuit withstand time as a function of gate-emitter voltage (V_{CE} =400V, start at T_{J} =25°C, T_{Jmax} <150°C)





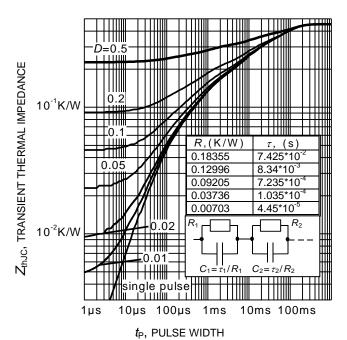
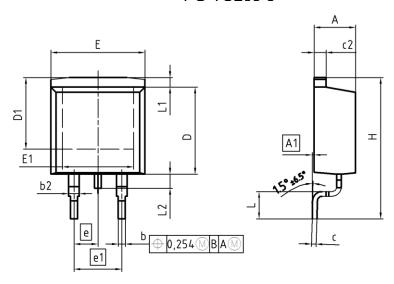


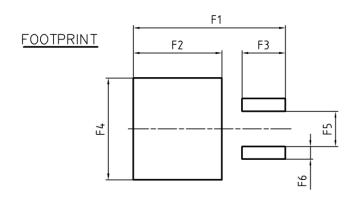
Figure 21. IGBT transient thermal impedance

 $(D = t_p / T)$

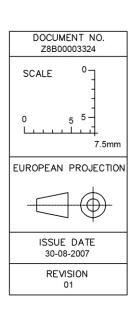


PG-TO263-3



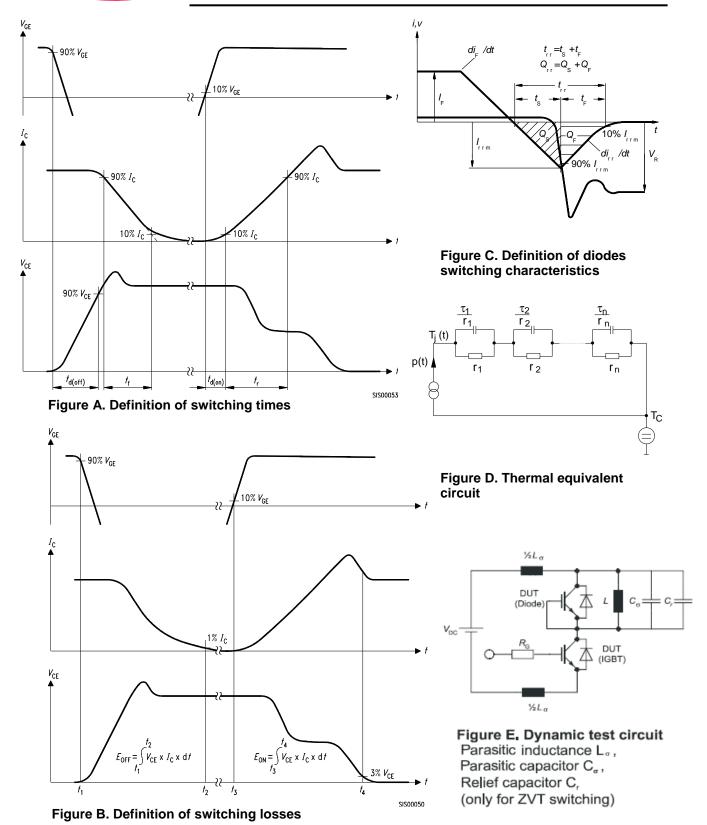


DIM	MILLIM	ETERS	INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	4.30	4.57	0.169	0.180	
A1	0.00	0.25	0.000	0.010	
b	0.65	0.85	0.026	0.033	
ь2	0.95	1.15	0.037	0.045	
С	0.33	0.65	0.013	0.026	
c2	1.17	1.40	0.046	0.055	
D	8.51	9.45	0.335	0.372	
D1	7.10	7.90	0.280	0.311	
E	9.80	10.31	0.386	0.406	
E1	6.50	8.60	0.256	0.339	
е	2.5	54	0.1	100	
e1	5.0	08	0.200		
N		2	2		
Н	14.61	15.88	0.575	0.625	
L	2.29	3.00	0.090	0.118	
L1	0.70	1.60	0.028	0.063	
L2	1.00	1.78	0.039	0.070	
F1	16.05	16.25	0.632	0.640	
F2	9.30	9.50	0.366	0.374	
F3	4.50	4.70	0.177	0.185	
F4	10.70	10.90	0.421	0.429	
F5	3.65	3.85	0.144	0.152	
F6	1.25	1.45	0.049	0.057	













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